## Issue Classification



CLASS

**ORIGINAL** 

**SUBCLASS** 

Application/Control No.	Applicant(s)/Patent Under Reexamination
• • •	,

CLAIMED

INTERNATIONAL CLASSIFICATION

NON-CLAIMED

10611634 AARON, JEFFREY A.

Examiner Art Unit

Elmira Mehrmanesh 2113

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CROSS REFERENCE(S)									_							
CLASS	SUB	CLASS (ONI	E SUBCLASS PER BLOCK)													
/Elmira Mehrmanesh/ 4/11/08									Total Claims Allowed:							
(Assistant Examiner) (Date)												24				
/Robert W Beausoliel Jr/					4/11/08					O.G. Print Claim(s)				O.G. Print Figure		
(Primary Examiner)					(Date)					1						
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Part of Paper No. 6